

<b>Notice of References Cited</b>	Application/Control No. 10/521,130		Applicant(s)/Patent Under Reexamination PINA, JEAN-BENOIT	
	Examiner CHARLES N. HICKS		Art Unit 2424	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0278737	12-2005	Ma et al.	725/040
*	B	US-2003/0122966	07-2003	Markman et al.	348/563
*	C	US-2005/0055716	03-2005	Louie et al.	725/058
*	D	US-2004/0015989	01-2004	Kaizu et al.	725/39
*	E	US-6,311,329	10-2001	Terakado et al.	725/44
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.